

# TLP3110

## Measurement Instruments

Logic IC Testers / Memory Testers

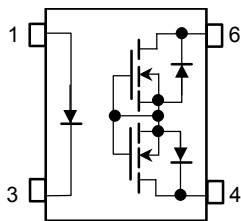
Board Testers / Scanners

The TOSHIBA mini flat photo relay TLP3110 is a small outline photo relay, suitable for surface mount assembly.

The TLP3110 consists of a GaAs infrared emitting diode optically coupled to a photo-MOSFET in a 4 pin lead package (MFSOP6), and has characteristics of small off-state current and small output terminal capacitance, which enable the TLP3110 to be applied to measurement instruments.

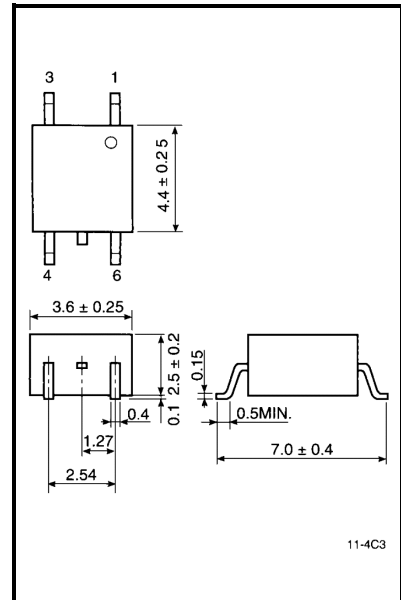
- 1-form-A
- Peak off-state voltage: 60 V (min.)
- Trigger LED current: 4 mA (max.)
- On-state current: 350 mA (max.)
- On-state resistance: 1.2 Ω (max.)
- Isolation voltage: 1500 V<sub>rms</sub> (min.)

## Pin Configuration (top view)



- 1 : Anode
- 3 : Cathode
- 4 : Drain
- 6 : Drain

Unit in mm



JEDEC	—
EIAJ	—
TOSHIBA	11-4C3

Weight: 0.1 g

## Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit
LED	Forward current	$I_F$	50	mA
	Reverse voltage	$V_R$	6	V
	Junction temperature	$T_j$	125	°C
Detector	Off-state output voltage	$V_{OFF}$	60	V
	On-state current	$I_{ON}$	350	mA
	Junction temperature	$T_j$	125	°C
Storage temperature		$T_{stg}$	-40~125	°C
Operating temperature		$T_{opr}$	-20~85	°C
Lead soldering temperature (10 s)		$T_{sol}$	260	°C
Isolation voltage (AC, 1 min., R.H.≤ 60%) (Note 1)		$BV_S$	1500	$V_{rms}$

(Note 1): Device considered a two-terminal device: Pins 1 and 3 shorted together, and pins 4 and 6 shorted together.

## Recommended Operating Conditions

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Supply voltage	$V_{OFF}$	—	—	48	V
Forward current	$I_F$	10	—	30	mA
On-state current	$I_{ON}$	—	—	350	mA
Operating temperature	$T_{opr}$	25	—	50	°C

## Individual Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min.	Typ.	Max.	Unit
LED	Forward voltage	$V_F$	$I_F = 20 \text{ mA}$	1.0	1.2	1.4	V
	Reverse voltage	$I_R$	$V_R = 6 \text{ V}$	—	—	10	$\mu\text{A}$
	Capacitance	$C_T$	$V = 0, f = 1 \text{ MHz}$	—	15	—	pF
Detector	Off-state current	$I_{OFF}$	$V_{OFF} = 30 \text{ V}, T_a = 50 \text{ °C}$	—	0.4	1	nA
	Capacitance	$C_{OFF}$	$V = 0, f = 1 \text{ MHz}$	—	100	150	pF

## Coupled Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Trigger LED current	$I_{FT}$	$I_{ON} = 350 \text{ mA}$	—	—	4	mA
On-state resistance	$R_{ON}$	$I_{ON} = 350 \text{ mA}, I_F = 5 \text{ mA}$	—	0.9	1.2	$\Omega$

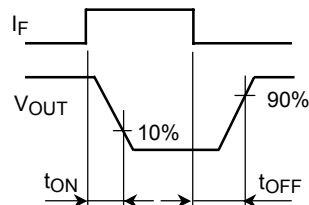
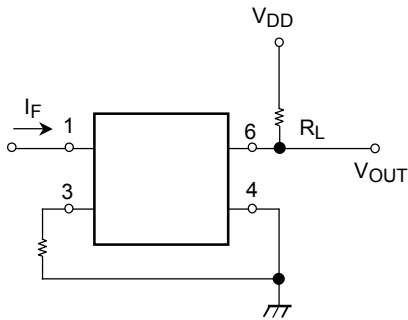
## Isolation Characteristics (Ta = 25°C)

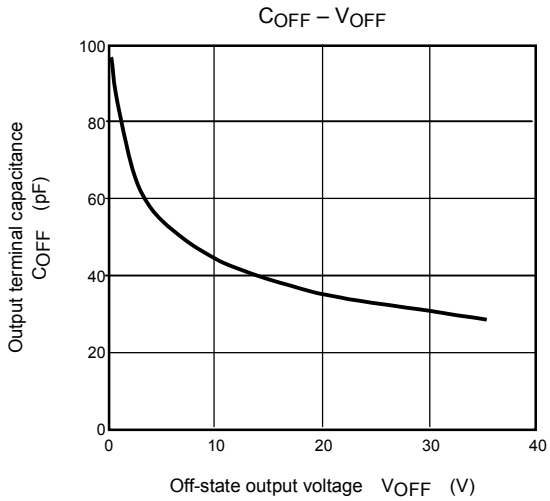
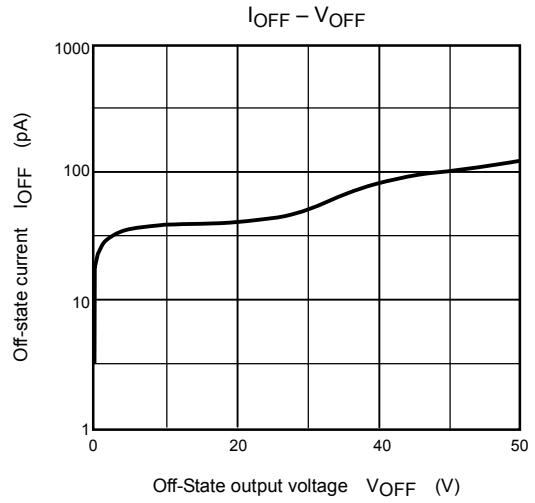
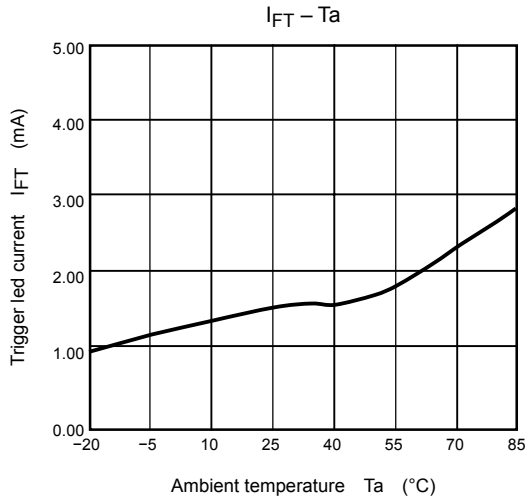
Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Capacitance input to output	$C_S$	$V_S = 0\text{ V}$ , $f = 1\text{ MHz}$	—	0.8	—	pF
Isolation resistance	$R_S$	$V_S = 500\text{ V}$ , R.H. $\leq 60\%$	$5 \times 10^{10}$	$10^{14}$	—	$\Omega$
Isolation voltage	$BV_S$	AC, 1 minute	1500	—	—	$V_{rms}$
		AC, 1 second (in oil)	—	3000	—	
		DC, 1 minute (in oil)	—	3000	—	$V_{dc}$

## Switching Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Turn-on time	$t_{ON}$	$R_L = 200\Omega$ (Note 2) $V_{DD} = 20\text{ V}$ , $I_F = 10\text{ mA}$	—	—	1	ms
Turn-off time	$t_{OFF}$		—	—	1	

(Note 2): Switching time test circuit





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